Atty. Docket No. Serial No. Form PTO-1449 (modified) 2000.093282/TT5101D Unknown List of Patents and Publications for Applicant's **Applicant** INFORMATION DISCLOSURE STATEMENT Andy C. Wei, Derick J. Wristers and Mark S. Fuselier Filing Date: Group: (Use several sheets if necessary) March 9, 2004 Unknown **U.S. Patent Documents Foreign Patent Documents** Other Art See Page 1 See Page 1 See Page 1 **U.S. Patent Documents** Exam. Ref. **Document** Date Name Class Sub Filing Date of Init. Des. Number Class App. A1 5,482871 01-1996 Pollack 438 BDI 151 **A2** 5,926,703 07-1999 Yamaguchi et al. 438 163 **A3** 6,232,163 05-2001 Voldman et al. 438 212 A4 6,352,882 03-2002 Assaderaghi et al. 438 155 **A5** 6,407,428 06-2002 Krishnan et al. 347 257 **Foreign Patent Documents** Exam. Ref. Document Translation Date Country Class Sub Init. Des. Number Yes/No Class BI B2 Other Art (Including Author, Title, Date Pertinent Pages, Etc.) Exam. Ref. Citation Init. Des. Baine et al., "Back Gate Effects in N-Channel Monocrystalline Silicon Devices-on-Glass and C1 SDI Their Suppression by Boron Ion Implantation," Mat. Res. Soc. Symp. Proc., 558:369-74, 2000 C2 Chang et al., "Efficacy of Air in Reducing the Kink Effect on Floating-Body NFD/SOI CMOS," Proc. 1998 IEEE Int'l SOI Conf., pp. 155-56, 1998 C3 Ko et al., "Suppression of Floating Body Effect with SIGE Source Structure for Fully Depleted SOI MOSFET's," Electrochem. Soc. Proc., 2001-3:239-44, 2001 C4 Leung et al., "High voltage, high speed lateral IGBT in thin SOI for power IC," SOI 1996 Int'l Conference Proceedings, pp. 132-133, 1996. **EXAMINER: DATE CONSIDERED:** EXAMINER: INITIAL IF REFERENCE CONSIDERED, WHETHER OR NOT CITATION IS IN CONFORMANCE WITH MPEP609; DRAW LINE THROUGH CITATION IF NOT IN CONFORMANCE AND NOT CONSIDERED. INCLUDE COPY OF THIS FORM WITH NEXT COMMUNICATION TO APPLICANT.

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